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# Structural and magnetic properties of nanocrystalline NiFe<sub>2</sub>O<sub>4</sub> thin film prepared by spray pyrolysis technique

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The nanocrystalline NiFe<sub>2</sub>O<sub>4</sub> thin film has been prepared using a spray pyrolysis technique on glass substrate. The prepared thin film was characterized by using X-ray diffraction (XRD), Fourier transform Infrared spectroscopy (FTIR), and Field Emission-Scanning Electron Microscopy (FE-SEM) characterization techniques for the structural and microstructural analysis. The magnetic property was measured using vibrating sample magnetometer (VSM) at room temperature. X-ray diffraction studies show the formation of single phase spinel structure of the thin film. The octahedral and tetrahedral vibration in the sample was studied by Fourier transform infrared (FT-IR) spectra. Magnetic hysteresis loop was recorded for thin film at room temperature. At 15 kOe, saturation magnetization (M<sub>s</sub>) was found to increase while coercivity (H<sub>c</sub>) decreases with thickness of the NiFe<sub>2</sub>O<sub>4</sub> thin film.

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## Topics

[Magnetic properties](#), [Magnetic equipment](#), [Magnetic hysteresis](#), [Glass](#), [Fourier transform spectroscopy](#), [Thin films](#), [X-ray diffraction](#), [Nanomaterials](#), [Pyrolysis](#), [Chemical compounds](#)

## REFERENCES

1. H. Arabi, N.K. Moghadam, *Journal of Magnetism and Magnetic Materials*, 335 (2013) 144–148. <https://doi.org/10.1016/j.jmmm.2013.02.006>  
[Google Scholar](#) [Crossref](#)
2. J.-G. Lee, J.Y. Park, Y.-J. Oh, C.S. Kim, *Journal of Applied Physics*, 84 (1998) 2801–2804. <https://doi.org/10.1063/1.368393>  
[Google Scholar](#) [Crossref](#)

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3. I. Sandu, L. Presmanes, P. Alphonse, P. Tailhades, *Thin Solid Films*, 495 (2006) 130–133. <https://doi.org/10.1016/j.tsf.2005.08.318>  
[Google Scholar](#) [Crossref](#)
4. O. Caltun, *Journal of Optoelectronics and Advanced Materials*, 7 (2005) 739–744.  
[Google Scholar](#)
5. J.-W. Park, M.G. Allen, *IEEE Transactions on magnetics*, 39 (2003) 3184–3186. <https://doi.org/10.1109/TMAG.2003.816051>  
[Google Scholar](#) [Crossref](#)
6. A. Ghasemi, *Journal of Magnetism and Magnetic Materials*, 324 (2012) 1375–1380. <https://doi.org/10.1016/j.jmmm.2011.11.044>  
[Google Scholar](#) [Crossref](#)
7. J.K. Howard, R.-H. Wang, *Google Patents*, 1988.  
[Google Scholar](#)
8. J.R. Scheffe, D. Weibel, A. Steinfeld, *Energy & Fuels*, 27 (2013) 4250–4257. <https://doi.org/10.1021/ef301923h>  
[Google Scholar](#) [Crossref](#)
9. T.P. Rao, M.S. Kumar, A. Safarulla, V. Ganesan, S. Barman, C. Sanjeeviraja, *Physica B: Condensed Matter*, 405 (2010) 2226–2231. <https://doi.org/10.1016/j.physb.2010.02.016>  
[Google Scholar](#) [Crossref](#)
10. A. Bagade, V. Ganbavle, K. Rajpure, *Journal of materials engineering and performance*, 23 (2014) 2787–2794. <https://doi.org/10.1007/s11665-014-1032-6>  
[Google Scholar](#) [Crossref](#)
11. J. Gunjekar, A. More, K. Gurav, C. Lokhande, *Applied Surface Science*, 254 (2008) 5844–5848. <https://doi.org/10.1016/j.apsusc.2008.03.065>  
[Google Scholar](#) [Crossref](#)
12. J. Gunjekar, A. More, V. Shinde, C. Lokhande, *Journal of Alloys and Compounds*, 465 (2008) 468–473. <https://doi.org/10.1016/j.jallcom.2007.10.130>  
[Google Scholar](#) [Crossref](#)
13. S. Chavan, M. Babrekar, S. More, K. Jadhav, *Journal of Alloys and Compounds*, 507 (2010) 21–25. <https://doi.org/10.1016/j.jallcom.2010.07.171>  
[Google Scholar](#) [Crossref](#)
14. S. Seifikar, T. Rawdanowicz, W. Straka, C. Quintero, N. Bassiri-

Gharb, J. Schwartz, *Journal of Magnetism and Magnetic Materials*, 361 (2014) 255–261. <https://doi.org/10.1016/j.jmmm.2014.03.004>

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